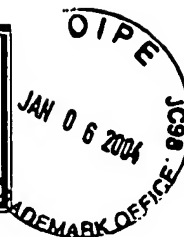


<b>FORM PTO-1449</b>  <b><u>INFORMATION DISCLOSURE CITATION</u></b>	Attorney Docket: 19877.0020 Applicants: Westerling et al. Filing Date: July 7, 2003	Application No.: 10/613,214 Examiner: -- Group Art Unit: 2856
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	REF. NO.	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS							
	REF. NO.	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION
	CA						
	CB						
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OTHER REFERENCES							
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AD	CK	S. Stuchly et al., Microwave Surface Level Monitor, IEEE Transactions on Industrial Electronics and Control Instrumentation, Vol. IECI-18, No. 3, August 1971					
	CL						
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Examiner <i>Ad6</i>	Date Considered <i>2/9/2005</i>
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<b>FORM PTO-1449</b>  <b>INFORMATION DISCLOSURE CITATION</b>	Attorney Docket: 19877.0020 Applicants: Westerling et al. Filing Date: July 7, 2003	Application No.: 10/613,214 Examiner: -- Group Art Unit: 2856
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AD	CK	M. Skolnik ed., Introduction to Radar Systems, McGraw-Hill Book Co., Inc. 1962, pp. 559-566
AD	CL	M. Skolnik ed., Radar Handbook, 1970, pp. 7-52, 11-1, 11-2, 26-26, 26-27
AD	CM	M. Skolnik ed., Radar Handbook, 2 <sup>nd</sup> Edition, 1990, pp. 9.16 - 9.18
AD	CN	D. Barton, Radars Volume 6, Frequency Agility and Diversity, 1977, pp. I-2, 111-3, IV-2, VI-1
	CO	
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Examiner <u>ADH</u>	Date Considered <u>2/9/2005</u>
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